

NX5P1000

Logic controlled high-side power switch

Rev. 2 — 14 January 2014

Product data sheet

1. General description

The NX5P1000 is an advanced power switch and ESD- protection device for USB OTG applications. The device includes under voltage and over voltage lockout, over-current, over-temperature, reverse bias and in-rush current protection circuits. These circuits are designed to isolate a VBUS OTG voltage source automatically from a VBUS interface pin when a fault condition occurs. The device features two power switch terminals, one input (VINT) and one output (VBUS). It has a current limit input (ILIM) for defining the over-current and in-rush current limit. A voltage detect output (VDET) is used to determine when VINT is in the correct voltage range. An open-drain fault output (FAULT) indicates when a fault condition has occurred and an enable input (EN) controls the state of the switch. When EN is set LOW the device enters a low-power mode, disabling all protection circuits except the undervoltage lockout. The low-power mode can be entered at anytime unless the over temperature protection circuit has been triggered.

Designed for operation from 3 V to 5.5 V, it is used in power domain isolation applications to protect from out of range operation. The enable input includes integrated logic level translation making the device compatible with lower voltage processors and controllers.

2. Features and benefits

- Wide supply voltage range from 3 V to 5.5 V
- 30 V tolerant on VBUS
- I_{SW} maximum 1 A continuous current
- Very low ON resistance: 100 m Ω (maximum) at a supply voltage of 4.0 V
- Low-power mode (ground current 20 μ A typical)
- 1.8 V control logic
- Soft start turn-on slew rate
- Protection circuitry
 - ◆ Over-temperature protection
 - ◆ Over-current protection with low current output mode
 - ◆ Reverse bias current/Back drive protection
 - ◆ Overvoltage lockout
 - ◆ Undervoltage lockout
 - ◆ Analog voltage limited VBUS monitor path
- ESD protection:
 - ◆ HBM ANSI/ESDA/JEDEC JS-001 Class 2 exceeds 2 kV
 - ◆ IEC61000-4-2 contact discharge exceeds 8 kV for pins VBUS, D $^-$, D $^+$ and ID
- Specified from -40 °C to $+85$ °C



3. Applications

- USB OTG applications

4. Ordering information

Table 1. Ordering information

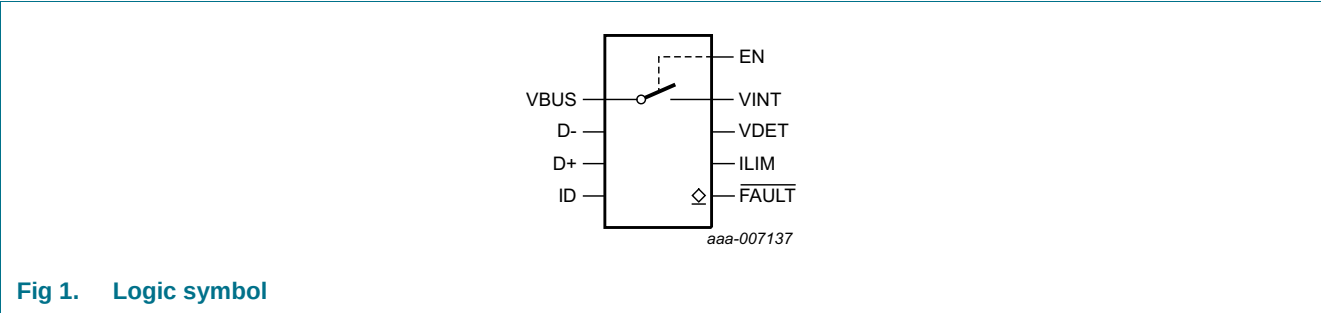
Type number	Package			
	Temperature range	Name	Description	Version
NX5P1000UK	−40 °C to +85 °C	WLCSP12	wafer level chip-scale package; 12 bumps; 1.36 × 1.66 × 0.51 mm, 0.4 mm pitch (Backside Coating included)	NX5P1000

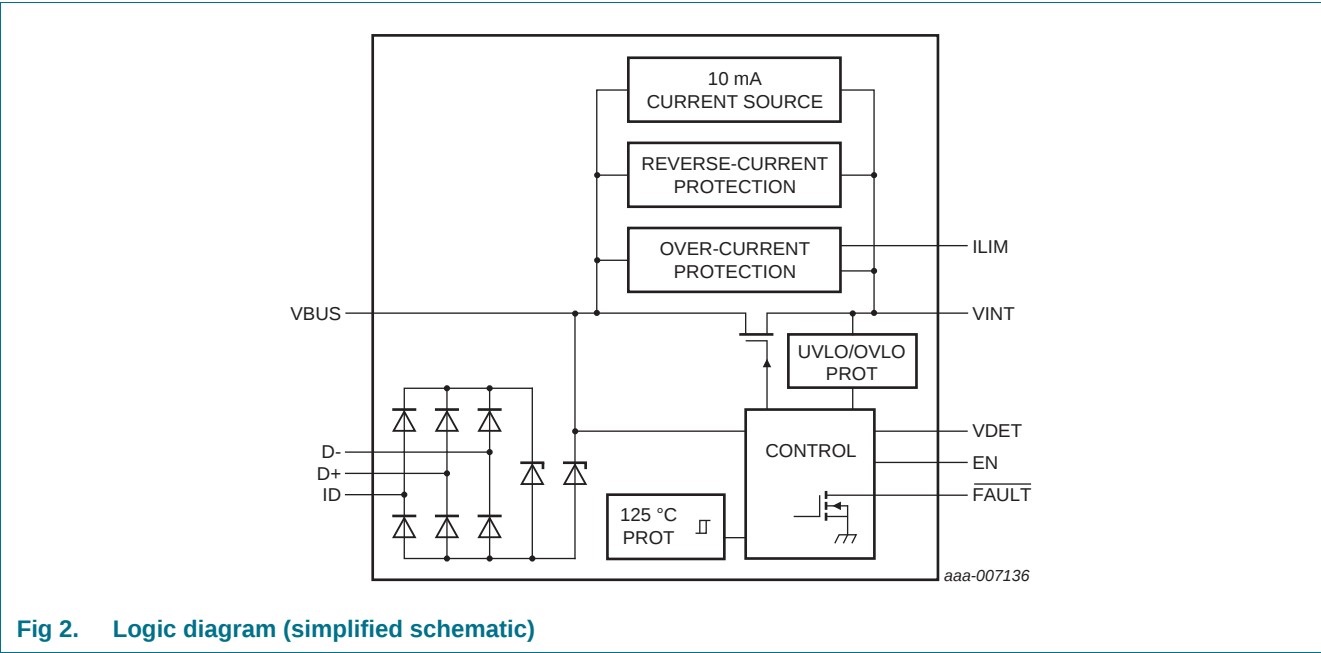
5. Marking

Table 2. Marking codes

Type number	Marking code
NX5P1000UK	NX5P1

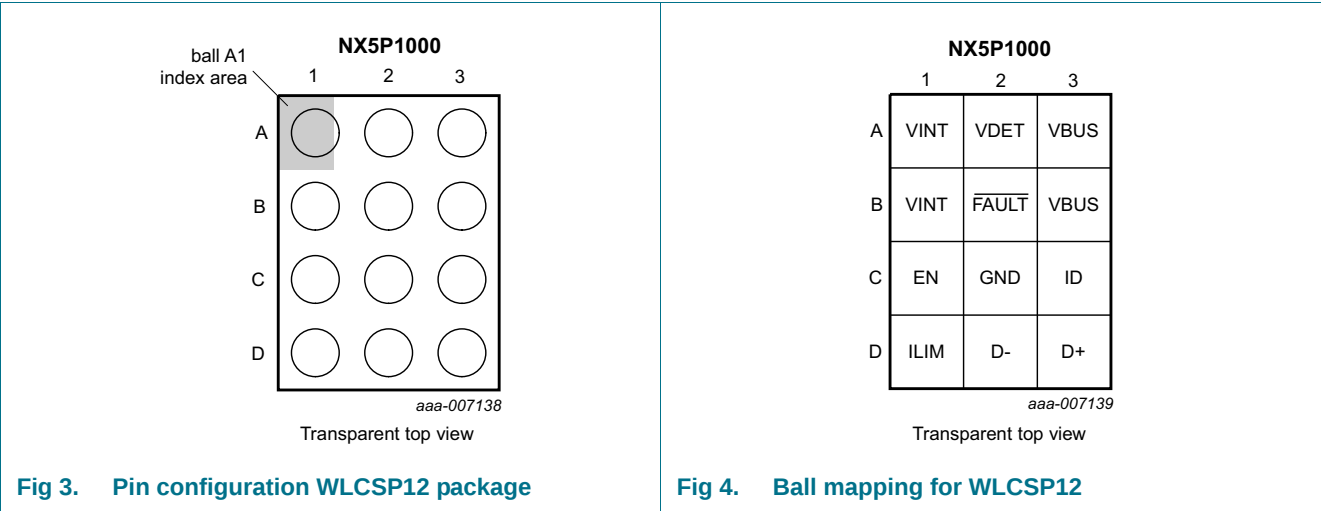
6. Functional diagram





7. Pinning information

7.1 Pinning



7.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
VINT	A1, B1	internal circuitry voltage I
VBUS	A3, B3	external connector voltage O
EN	C1	enable input (active HIGH) I
ILIM	D1	current limiter I/O

Table 3. Pin description ...continued

Symbol	Pin	Description
VDET	A2	VBUS voltage level indicator O
FAULT	B2	fault condition indicator (open-drain; active LOW)
GND	C2	ground (0 V)
D-	D2	ESD-protection I/O
D+	D3	ESD-protection I/O
ID	C3	ESD-protection I/O

8. Functional description

Table 4. Function table^[1]

EN	VINT	VBUS	FAULT	Operation mode
X	0 V	Z	L	no supply
X	0 V	< 30 V	Z	disabled; switch open
X	< 3.2 V	Z	L	undervoltage lockout; switch open
H	> 5.5 V	Z	L	overvoltage lockout; switch open
H	3.2 V to 5.5 V	Z	L	over-temperature; switch open
L	3.2 V to 5.5 V	Z	Z	disabled; switch open
H	3.2 V to 5.5 V	VBUS = VINT	Z	enabled; switch closed; active
H	3.2 V to 5.5 V	0 V to VINT	L	over-current; switch open; constant current on VBUS
H	3.2 V to 5.5 V	0 V to VINT	L	when ILIM is connected to GND, VBUS is supplied with 10 mA current source
H	3.2 V to 5.5 V	$VINT + 30 \text{ mV} < VBUS < VINT + 0.45 \text{ V} (> 4 \text{ ms})$	L	reverse bias current/back drive; switch open
H	3.2 V to 5.5 V	$VBUS > VINT + 0.45 \text{ V}$	L	reverse bias current/back drive; switch open

[1] H = HIGH voltage level; L = LOW voltage level, Z = high-impedance OFF-state, X = Don't care.

Table 5. Function table VDET versus VBUS^[1]

VBUS	VDET	Operation mode
$3 \text{ V} < VBUS < 30 \text{ V}$	$1.5 < VDET < 5.5 \text{ V}$	VDET detects VBUS voltage

[1] See [Figure 22](#).

8.1 EN input

When the EN is set LOW, the N-channel MOSFET is disabled. The device enters low-power mode disabling all protection circuits except the undervoltage lockout circuit and setting the **FAULT** output high impedance. When EN is set HIGH, all protection circuits are enabled. If an R_{LIM} current limit resistor is detected and no fault conditions exist, the N-channel MOSFET is enabled.

8.2 Undervoltage lockout

Independent of the logic level on the EN pin, the undervoltage lockout (UVLO) circuit disables the N-channel MOSFET. It sets the **FAULT** output LOW and enters low-power mode until $VINT > 3.2 \text{ V}$. Once $VINT > 3.2 \text{ V}$, the state of the N-channel MOSFET controls the EN pin. The UVLO circuit remains active in low-power mode.

8.3 Overvoltage lockout

When EN is set HIGH, the overvoltage lockout (OVLO) circuit disables the N-channel MOSFET. If $V_{INT} > 5.75\text{ V}$, the $\overline{\text{FAULT}}$ output is set LOW. The OVLO circuit is disabled in low-power mode and does not influence the $\overline{\text{FAULT}}$ output state. If the OVLO circuit is active, setting the EN pin LOW returns the device to low-power mode.

8.4 ILIM

The over-current protection circuit's (OCP) trigger value I_{ocp} , can be set using an external resistor R_{ILIM} connected to the ILIM pin (see [Figure 6](#)). When EN is set HIGH and the ILIM pin is grounded, the N-channel MOSFET is disabled. In addition, VBUS is supplied by the 10 mA current source and the $\overline{\text{FAULT}}$ output set LOW.

8.5 Over-current protection

If the current through the N-channel MOSFET exceeds I_{ocp} for 20 μs or $V_{BUS} < V_{INT} - 200\text{ mV}$, the over-current protection (OCP) circuit disables the N-channel MOSFET within 2 μs . It supplies VBUS from the 10 mA current source and indicates a fault condition by setting the $\overline{\text{FAULT}}$ pin LOW. The OCP circuit is automatically reset when $V_{INT} > V_{BUS} > V_{INT} - 200\text{ mV}$ for 20 μs . The N-channel MOSFET assumes the state defined by the EN input, the 10 mA current source is disconnected and the $\overline{\text{FAULT}}$ pin is set high impedance. If the OCP circuit is active, setting the EN pin LOW returns the device to low-power mode.

8.6 Over-temperature protection

When EN is set HIGH and the device temperature exceeds 125 °C, the Over-temperature protection (OTP) circuit disables the N-channel MOSFET. It indicates a fault condition by setting the $\overline{\text{FAULT}}$ pin LOW. Any transition on the EN pin has no effect. Once the device temperature decreases to below 115 °C, the device returns to the defined state. The OTP circuit is disabled in low-power mode. However, if the OTP circuit is active, setting the EN pin LOW does not return the device to low-power mode.

8.7 Reverse bias current/back drive protection

When EN is set HIGH, if $(V_{INT} + 30\text{ mV}) < V_{BUS} < (V_{INT} + 0.45\text{ V})$ for longer than 4 ms, or if $V_{BUS} > (V_{INT} + 0.45\text{ V})$, the reverse-bias current protection circuit (RCP) disables the N-channel MOSFET. It indicates a fault condition by setting the $\overline{\text{FAULT}}$ pin LOW. Once $V_{BUS} < V_{INT}$ for longer than 4 ms the device returns to the defined state. If the RCP circuit is active, setting the EN pin LOW returns the device to low-power mode.

8.8 $\overline{\text{FAULT}}$ output

The $\overline{\text{FAULT}}$ output is an open-drain output that requires an external pull-up resistor. If any of the UVLO, OVLO, RCP, OCP or OTP circuits are activated the $\overline{\text{FAULT}}$ output is set LOW to indicate a fault has occurred. The $\overline{\text{FAULT}}$ output returns to the high impedance state automatically once the fault condition is removed.

8.9 VDET output

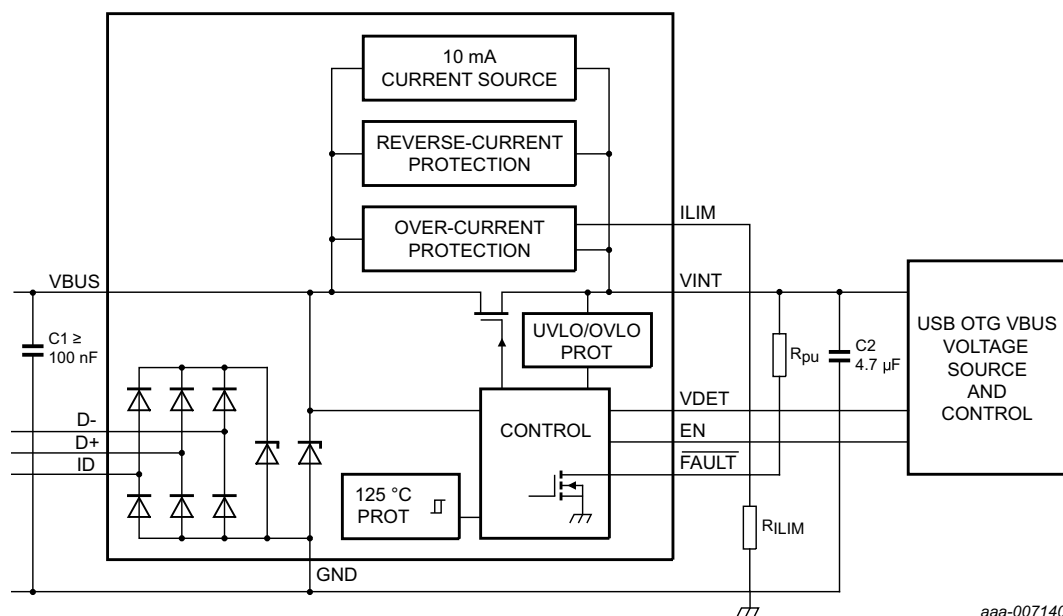
VDET is an analog output that allows a controller to monitor the voltage level on VBUS.

8.10 In-rush current protection

When either the EN pin or a recovered fault condition enables the N-channel MOSFET, the in-rush current protection circuit affects the switch. It causes the switch to behave as a current source during the time VBUS ramps up to $V_{INT} - 200\text{ mV}$. The resistor connected to ILIM determines the current. The in-rush current protection circuit is disabled in low-power mode.

9. Application diagram

The NX5P1000 typically connects a voltage source on VINT to the VBUS of a USB connector supporting USB3 OTG in a portable, battery operated device. The external resistor R_{ILIM} sets the maximum current limit threshold. The $\overline{\text{FAULT}}$ signal requires an additional external pull-up resistor. This resistor should be connected to a supply voltage matching the logic input pin supply level it is connected to.



aaa-007140

Fig 5. NX5P1000 application diagram

10. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V _I	input voltage	VBUS	[1] -0.5	+32	V
		VINT	[1] -0.5	+6.0	V
		EN, ILIM	[2] -0.5	VINT + 0.5	V
		D-, D+, ID	[1] -0.5	+6.0	V
V _O	output voltage	FAULT	-0.5	+6.0	V
I _{IK}	input clamping current	EN: V _I < -0.5 V	-50	-	mA
I _{SK}	switch clamping current	VBUS; VINT; V _I < -0.5 V	-50	-	mA
I _{SW}	switch current	T _{amb} = 85 °C	-	±1000	mA
T _{j(max)}	maximum junction temperature		-40	+125	°C
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation		[3] -	100	mW

- [1] The minimum and maximum switch voltage ratings may be exceeded if the switch clamping current rating is observed.
- [2] The minimum input voltage rating may be exceeded if the input current rating is observed.
- [3] The (absolute) maximum power dissipation depends on the junction temperature T_j. Higher power dissipation is allowed in conjunction with lower ambient temperatures. The conditions to determine the specified values are T_{amb} = 85 °C and the use of a two layer PCB.

11. Recommended operating conditions

Table 7. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
V _I	input voltage	VINT	3.0	5.5	V
		EN, ILIM	0	VINT	V
V _O	output voltage	VBUS; EN = LOW	0	30	V
V _{I/O}	input/output voltage	D-, D+, ID	0	5.5	V
T _{amb}	ambient temperature		-40	+85	°C

12. Thermal characteristics

Table 8. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
R _{th(j-a)}	thermal resistance from junction to ambient		[1][2] 73	K/W

- [1] The overall R_{th(j-a)} can vary depending on the board layout. To minimize the effective R_{th(j-a)}, all pins must have a solid connection to larger Cu layer areas e.g. to the power and ground layer. In multi-layer PCB applications, the second layer should be used to create a large heat spreader area right below the device. If this layer is either ground or power, it should be connected with several vias to the top layer connecting to the device ground or supply. Try not to use any solder-stop varnish under the chip.
- [2] Rely on the measurement data given for a rough estimation of the R_{th(j-a)} in your application. The actual R_{th(j-a)} value may vary in applications using different layer stacks and layouts

13. Static characteristics

Table 9. Static characteristics

$V_{I(VINT)} = 4.0\text{ V to }5.5\text{ V}$; unless otherwise specified; Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T _{amb} = 25 °C			T _{amb} = -40 °C to +85 °C		Unit
			Min	Typ ^[1]	Max	Min	Max	
V _{IH}	HIGH-level input voltage	EN input	1.2	-	-	1.2	-	V
V _{IL}	LOW-level input voltage	EN input	-	-	0.4	-	0.4	V
V _O	output voltage	VDET; I _{VDET} = -2 mA; 3 V < V _{BUS} < 30 V	1.5	-	5.5	1.5	5.5	V
V _{OL}	LOW-level output voltage	FAULT, I _O = 8 mA	-	-	0.5	-	0.5	V
I _O	output current	Current source	-	10	-	8	15	mA
		EN = HIGH; FAULT = Hi-Z	-	-	I _{OS}	-	I _{OS}	mA
I _{ocp}	overcurrent protection current	EN = HIGH; see Figure 6	-	-	-	-	-	mA
R _{pu}	pull-up resistance	FAULT	20	-	200	-	-	kΩ
V _{pu}	pull-up voltage	FAULT	-	-	VINT	-	VINT	V
R _{ILIM}	current limit resistance	ILIM	40	-	300	40	300	kΩ
I _{GND}	ground current	VBUS open; EN = LOW; see Figure 7 and Figure 8	-	20	-	-	40	μA
		VBUS open; EN = HIGH; see Figure 7 and Figure 8	-	220	-	-	330	μA
I _{OFF}	power-off leakage current	VBUS = 0 V to 30 V; VINT = 0 V; see Figure 9 ^[2]	-	2	-	-	20	μA
I _{S(OFF)}	OFF-state leakage current	VBUS = 0 V to 30 V; see Figure 10 and Figure 11 ^[2]	-	2	-	-	20	μA
V _{UVLO}	undervoltage lockout voltage		3.0	3.2	3.4	3.0	3.4	V
V _{OVLO}	overvoltage lockout voltage		5.5	5.75	6.0	5.5	6.0	V
V _{hys(OVLO)}	overvoltage lockout hysteresis voltage		-	150	-	-	-	mV
C _{I/O}	input/output capacitance	D-, D+, ID	-	3	-	-	-	pF
C _I	input capacitance	EN	-	2	-	-	-	pF
C _{S(ON)}	ON-state capacitance		-	-	1	-	1	nF

[1] Typical values are measured at T_{amb} = 25 °C and V_{I(VINT)} = 5.0 V.

[2] Typical value is measured at T_{amb} = 25 °C and V_{I(VBUS)} = 5.0 V.

13.1 Graphs

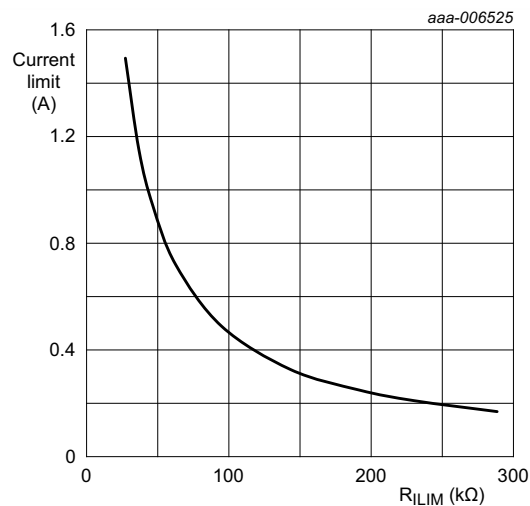
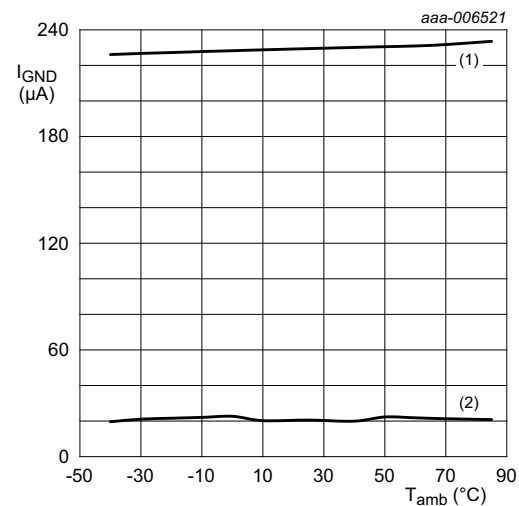


Fig 6. Typical over-current and in-rush current limit versus the external resistor value.



- (1) Enabled
- (2) Disabled

Fig 7. Typical ground current versus temperature

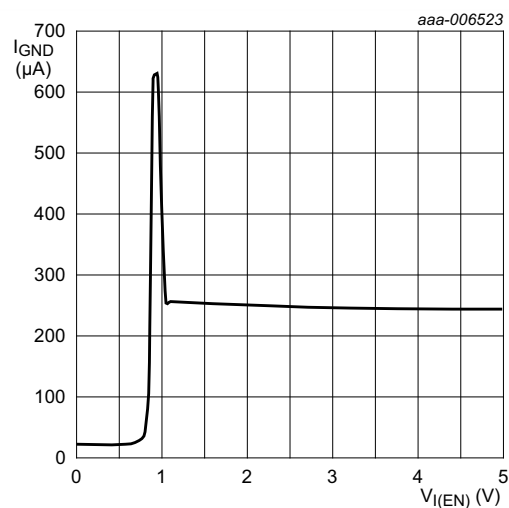
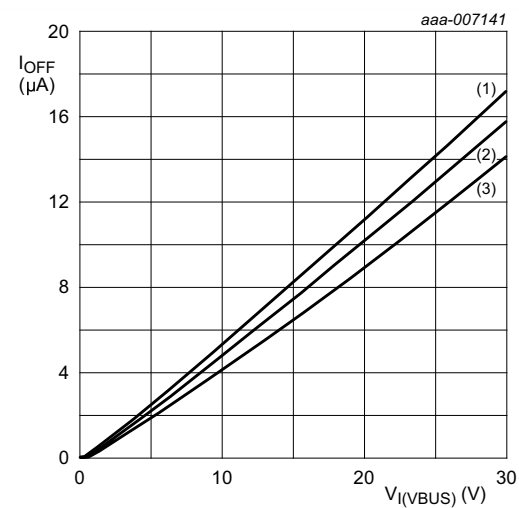
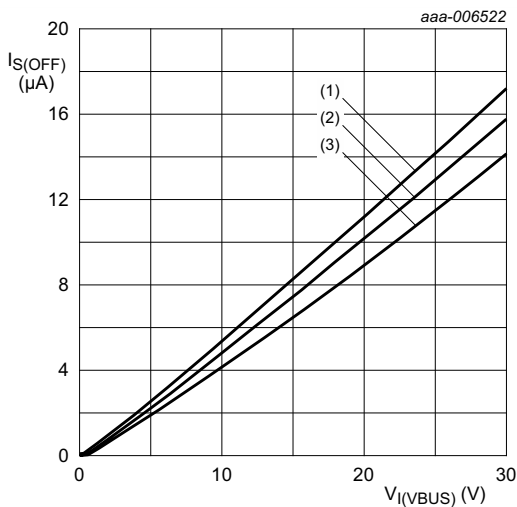


Fig 8. Typical ground current versus input voltage



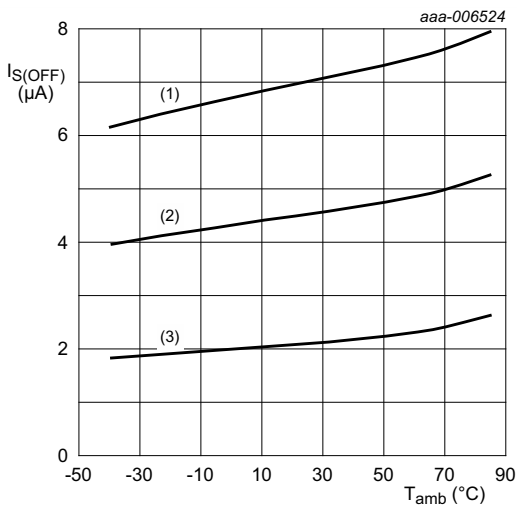
- (1) $T_{amb} = 85\text{ }^{\circ}\text{C}$
- (2) $T_{amb} = 25\text{ }^{\circ}\text{C}$
- (3) $T_{amb} = -40\text{ }^{\circ}\text{C}$

Fig 9. Typical power-off leakage current versus input voltage on pin VBUS



- (1) $T_{amb} = 85\text{ }^{\circ}\text{C}$
- (2) $T_{amb} = 25\text{ }^{\circ}\text{C}$
- (3) $T_{amb} = -40\text{ }^{\circ}\text{C}$

Fig 10. Typical OFF-state leakage current versus input voltage on pin VBUS



- (1) $V_{I(VBUS)} = 15.0\text{ V}$
- (2) $V_{I(VBUS)} = 10.0\text{ V}$
- (3) $V_{I(VBUS)} = 5.0\text{ V}$

Fig 11. Typical OFF-state leakage current versus temperature

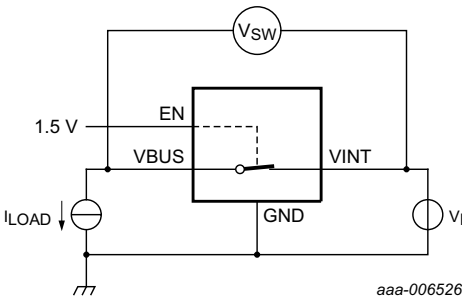
13.2 ON resistance

Table 10. ON resistance

At recommended operating conditions; voltages are referenced to GND (ground = 0 V)

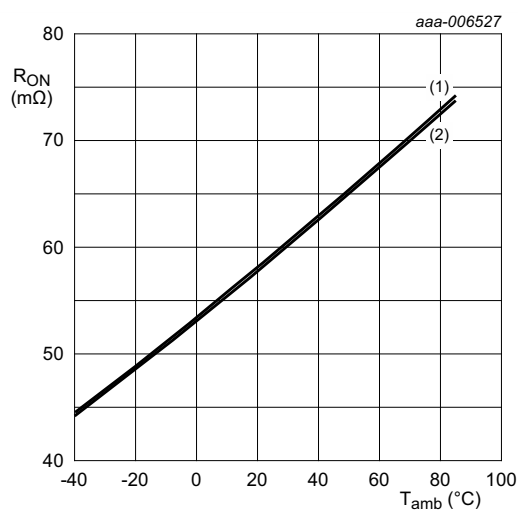
Symbol	Parameter	Conditions	$T_{amb} = 25\text{ }^{\circ}\text{C}$			$T_{amb} = -40\text{ }^{\circ}\text{C to } +85\text{ }^{\circ}\text{C}$		Unit
			Min	Typ	Max	Min	Max	
R_{ON}	ON resistance	switch enabled; $I_{LOAD} = 200\text{ mA}$; see Figure 12 , Figure 13 and Figure 14 $V_{I(VINT)} = 4.0\text{ V to } 5.5\text{ V}$	-	60	-	-	100	mΩ

13.3 ON resistance test circuit and waveforms



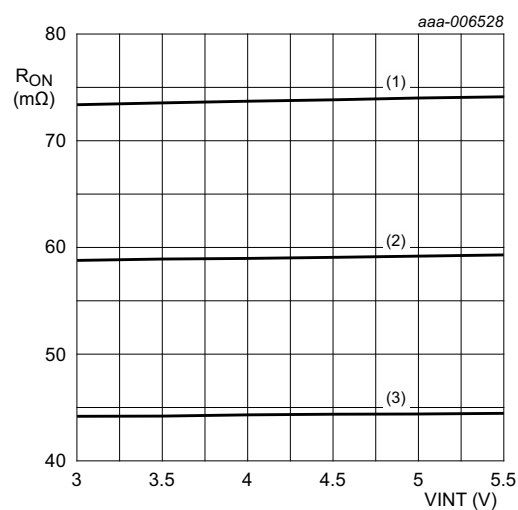
$R_{ON} = V_{SW} / I_{LOAD}$

Fig 12. Test circuit for measuring ON resistance



- (1) $V_{I(VINT)} = 5.5 \text{ V}$
 (2) $V_{I(VINT)} = 4.0 \text{ V}$

Fig 13. Typical ON resistance versus temperature



- (1) $T_{amb} = 85 \text{ °C}$
 (2) $T_{amb} = 25 \text{ °C}$
 (3) $T_{amb} = -40 \text{ °C}$

Fig 14. Typical ON resistance versus input voltage

14. Dynamic characteristics

Table 11. Dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see [Figure 16](#).
 $V_{I(VINT)} = 4.0 \text{ V to } 5.5 \text{ V}$.

Symbol	Parameter	Conditions	T _{amb} = 25 °C			T _{amb} = -40 °C to +85 °C		Unit
			Min	Typ	Max	Min	Max	
t _{en}	enable time	EN to VBUS; see Figure 15	-	0.24	-	0.16	-	ms
t _{dis}	disable time	EN to VBUS; see Figure 15	-	1.5	-	-	-	ms
t _{on}	turn-on time	EN to VBUS; see Figure 15	-	0.63	-	0.52	-	ms
t _{off}	turn-off time	EN to VBUS; see Figure 15	-	34.5	-	-	-	ms
t _{TLH}	LOW to HIGH output transition time	VBUS; see Figure 15	-	0.39	-	0.16	-	ms
t _{THL}	HIGH to LOW output transition time	VBUS; see Figure 15	-	33	-	-	-	ms

14.1 Waveforms, graphs and test circuit

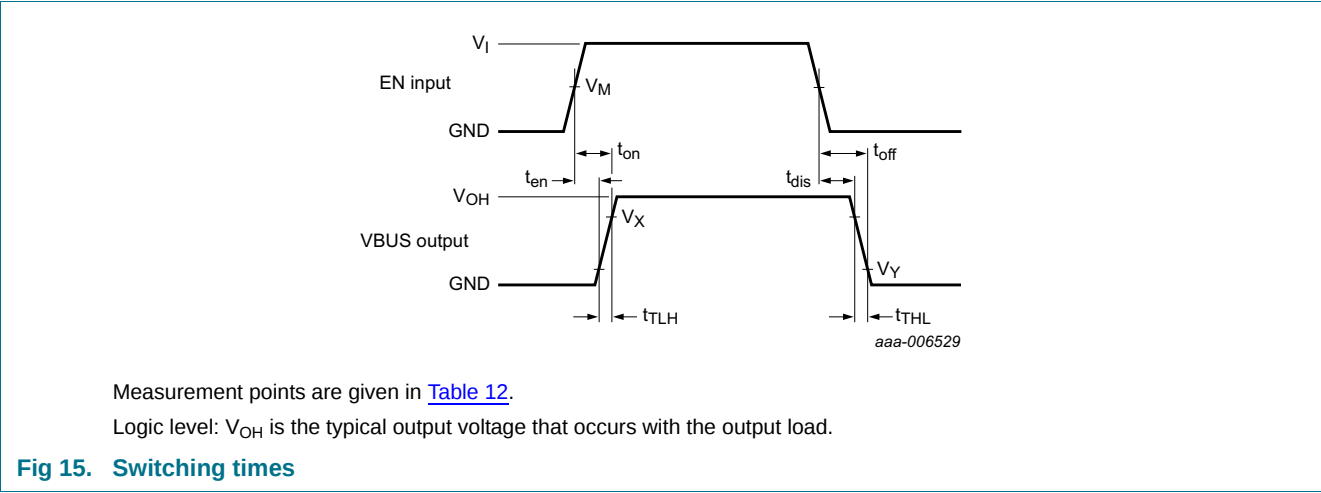


Table 12. Measurement points

Supply voltage	EN Input	Output	
$V_{I(VINT)}$	V_M	V_X	V_Y
4.0 V to 5.5 V	$0.5 \times V_I$	$0.9 \times V_{OH}$	$0.1 \times V_{OH}$

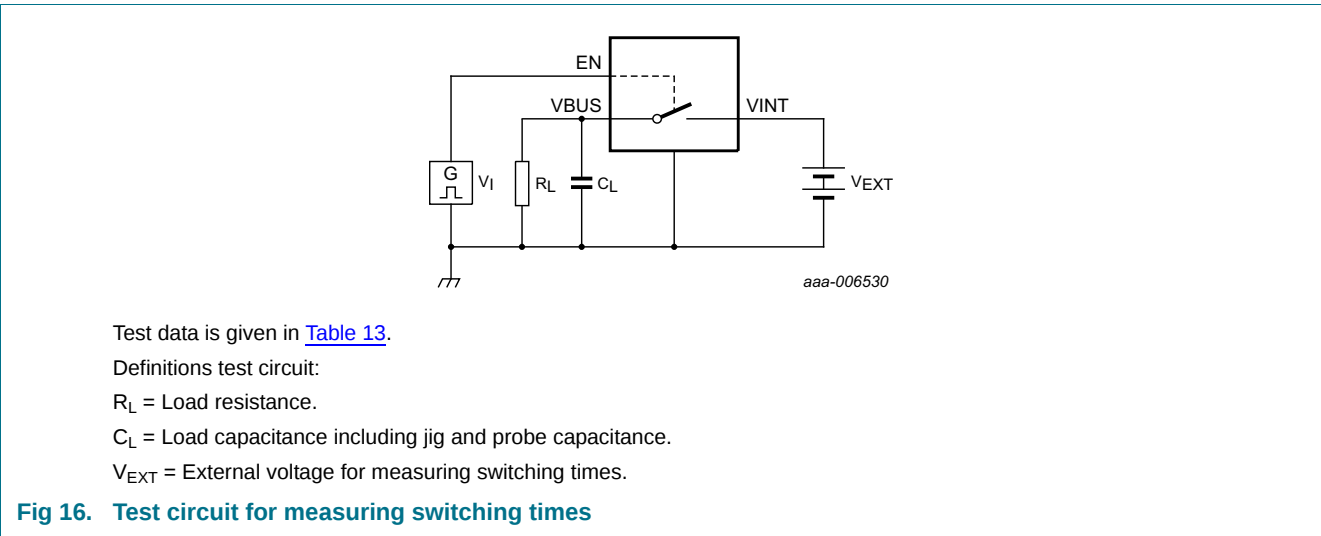
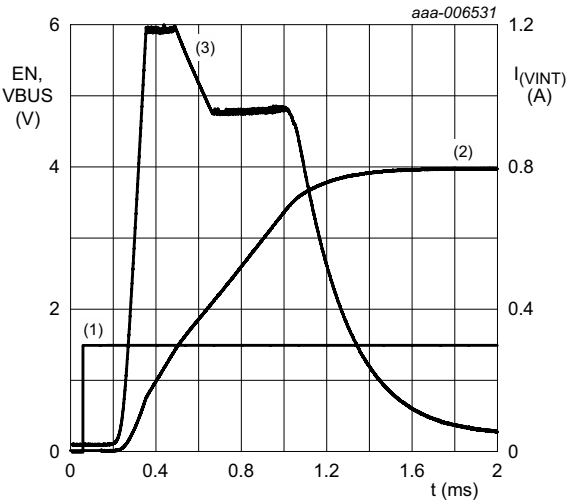


Table 13. Test data

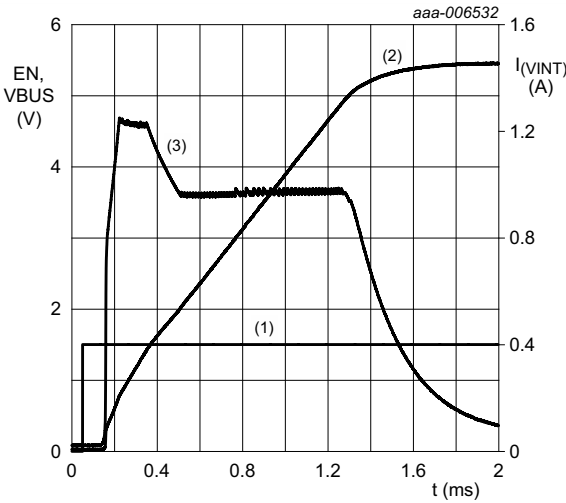
Supply voltage	Input	Load	
V_{EXT}	V_I	C_L	R_L
4.0 V to 5.5 V	1.5 V	100 μ F	150 Ω



EN = 1.5 V; VINT = 4 V; $R_L = 150 \Omega$; $C_L = 220 \mu F$;
 $R_{ILIM} = 50 k\Omega$; $T_{amb} = 25 ^\circ C$.

- (1) EN
- (2) VBUS
- (3) $I_{(VINT)}$

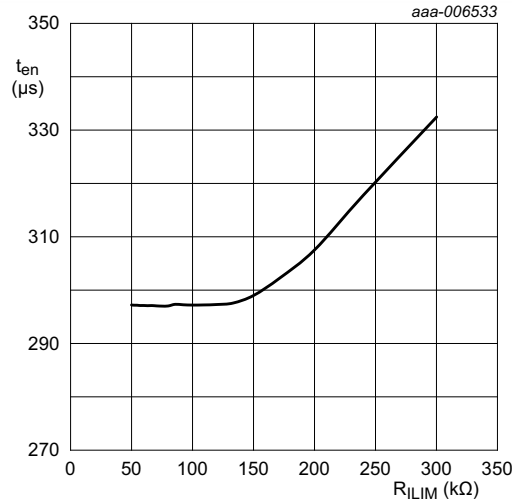
Fig 17. Typical enable time and in-rush current



EN = 1.5 V; VINT = 5.5 V; $R_L = 150 \Omega$; $C_L = 220 \mu F$;
 $R_{ILIM} = 50 k\Omega$; $T_{amb} = 25 ^\circ C$.

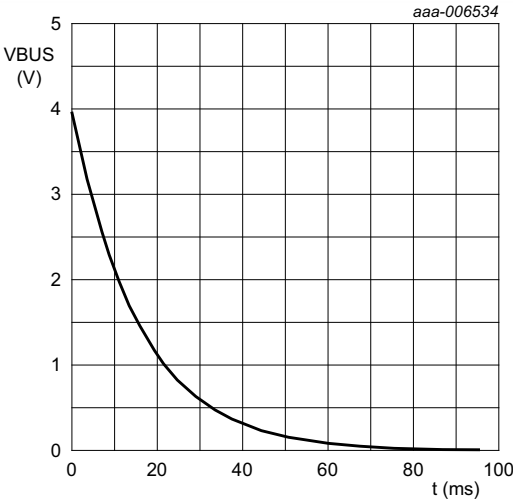
- (1) EN
- (2) VBUS
- (3) $I_{(VINT)}$

Fig 18. Typical enable time and in-rush current



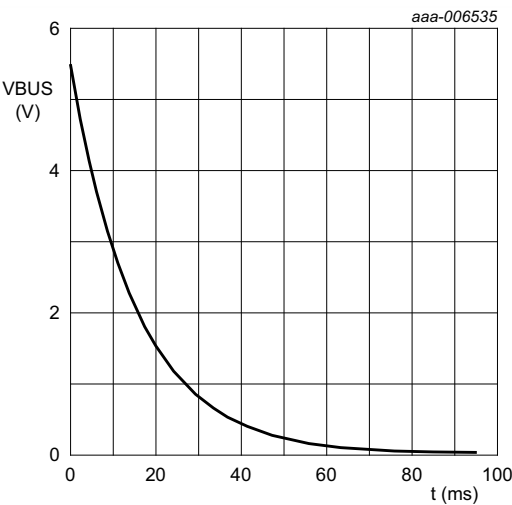
EN = 1.5 V; VINT = 4 V; $R_L = 150 \Omega$; $C_L = 100 \mu F$;
 $T_{amb} = 25 ^\circ C$.

Fig 19. Typical enable time versus current limit resistance (R_{ILIM})



EN = 1.5 V; VINT = 4 V; $R_L = 150 \Omega$; $C_L = 100 \mu F$;
 $R_{ILIM} = 50 k\Omega$; $T_{amb} = 25 ^\circ C$.

Fig 20. Typical disable time



EN = 1.5 V; VINT = 5.5 V; $R_L = 150\ \Omega$; $C_L = 100\ \mu\text{F}$;
 $R_{\text{ILIM}} = 50\ \text{k}\Omega$; $T_{\text{amb}} = 25\ ^\circ\text{C}$.

Fig 21. Typical disable time

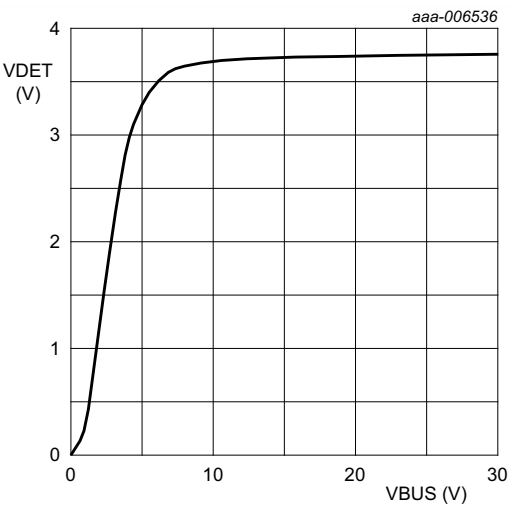


Fig 22. Typical VDET versus VBUS

15. Package outline

WLCSP12: wafer level chip-scale package;
12 bumps; 1.36 x 1.66 x 0.51 mm, 0.4 mm pitch (Backside coating included)

NX5P1000

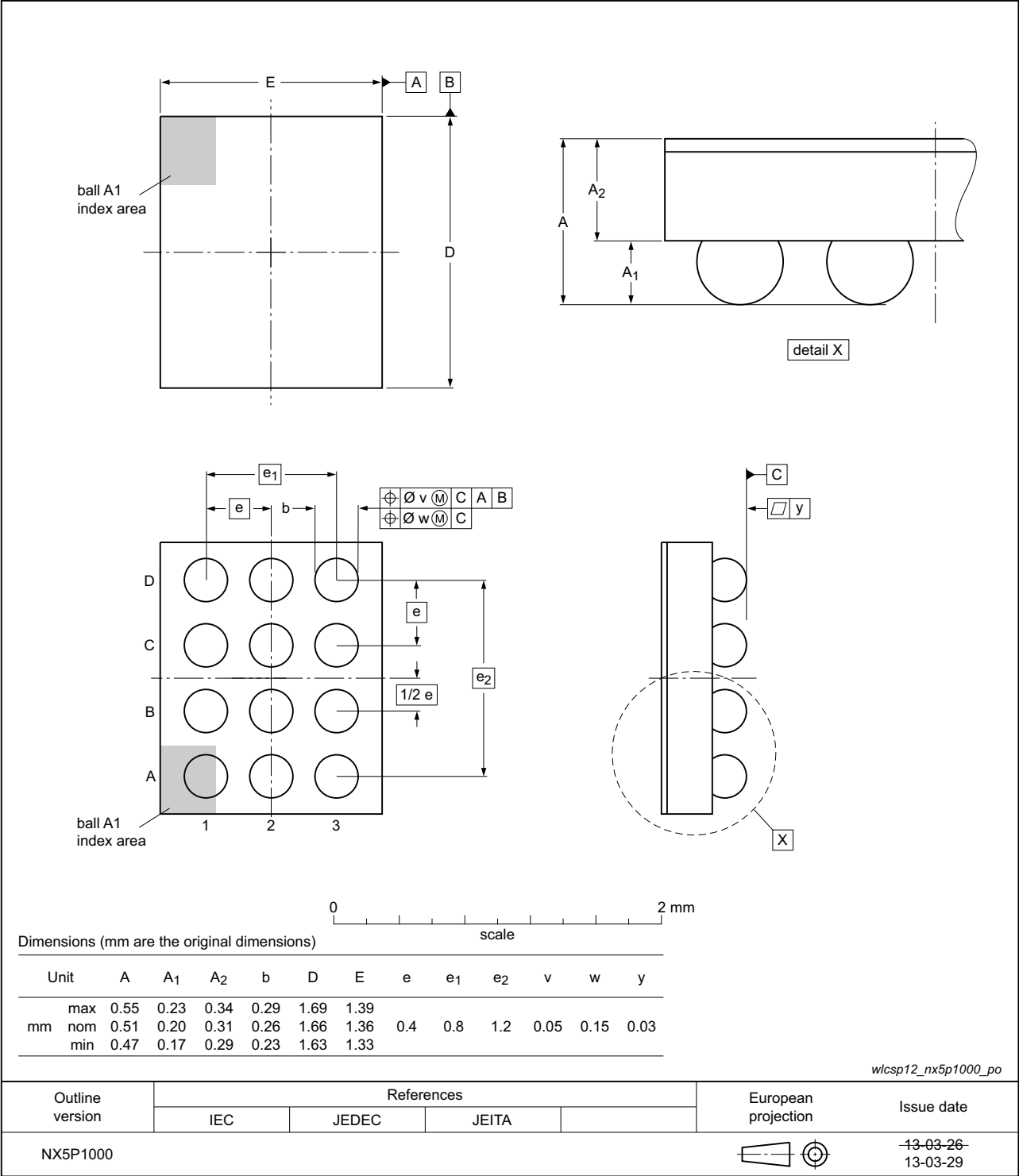


Fig 23. Package outline NX5P1000 (WLCSP12)

16. Abbreviations

Table 14. Abbreviations

Acronym	Description
CDM	Charged Device Model
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MOSFET	Metal-Oxide Semiconductor Field Effect Transistor
OCP	Overcurrent Protection
OTP	Overtemperature Protection
RCP	Reverse Current Protection
USB OTG	Universal Serial Bus On-The-Go
UVLO	Undervoltage lockout
VBUS	USB Power Supply
OVLO	Overvoltage lockout

17. Revision history

Table 15. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
NX5P1000 v.2	20140114	Product data sheet	-	NX5P1000 v.1
Modifications:	• I_{OS} changed into I_{ocp} (errata).			
NX5P1000 v.1	20130429	Product data sheet	-	-

18. Legal information

18.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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Date of release: 14 January 2014

Document identifier: NX5P1000

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